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P-Channel 1.5 V Specified PowerTrench[®] Thin WL-CSP MOSFET -20 V, -3.7 A, 75 m Ω

Features

- Max $r_{DS(on)} = 75 \text{ m}\Omega$ at $V_{GS} = -4.5 \text{ V}$, $I_D = -2.0 \text{ A}$
- Max $r_{DS(on)}$ = 90 m Ω at V_{GS} = -2.5 V, I_D = -1.5 A
- Max $r_{DS(on)}$ = 110 m Ω at V_{GS} = -1.8 V, I_D = -1.0 A
- Max $r_{DS(on)}$ = 150 m Ω at V_{GS} = -1.5 V, I_D = -1.0 A
- Occupies only 1.0 mm² of PCB area.Less than 30% of the area of 2 x 2 BGA
- Ultra-thin package: less than 0.4 mm height when mounted to PCB
- HBM ESD protection level >4.4kV typical (Note 3)
- RoHS Compliant

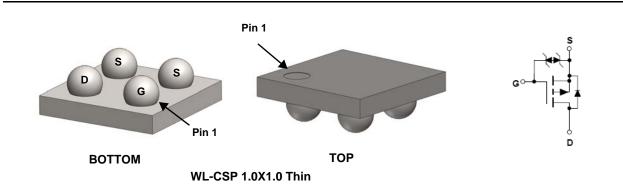


General Description

Designed on Fairchild's advanced 1.5 V PowerTrench[®] process with state of the art "fine pitch" Thin WLCSP packaging process, the FDZ371PZ minimizes both PCB space and $r_{DS(on)}$. This advanced WLCSP MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, ultra-low profile packaging, low gate charge, and low $r_{DS(on)}$.

Applications

- Battery management
- Load switch
- Battery protection



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

| Symbol | Parameter | | | Ratings | Units | |
|-----------------------------------|--------------------------------------------------|-----------------------|-----------|-------------|-------|--|
| V _{DS} | Drain to Source Voltage | | | -20 | V | |
| V _{GS} | Gate to Source Voltage | | | ±8 | V | |
| I | -Continuous | T _A = 25°C | (Note 1a) | -3.7 | ٨ | |
| D | -Pulsed | | | -12 | A | |
| D | Power Dissipation | T _A = 25°C | (Note 1a) | 1.7 | w | |
| P _D | Power Dissipation | T _A = 25°C | (Note 1b) | 0.5 | | |
| T _J , T _{STG} | Operating and Storage Junction Temperature Range | | | -55 to +150 | °C | |

Thermal Characteristics

| $R_{	ext{	heta}JA}$ | Thermal Resistance, Junction to Ambient | (Note 1a) | 75 | °C/W |
|---------------------|-----------------------------------------|-----------|-----|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | (Note 1b) | 260 | C/VV |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|----------|---------------------|-----------|------------|------------|
| K | FDZ371PZ | WL-CSP 1.0X1.0 Thin | 7 " | 8 mm | 5000 units |

July 2014

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|----------------------------------------|-------------------------------------------------------------|-----------------------------------------------------------------------------|-------|------|------|-------|
| Off Chara | acteristics | | | | | |
| BV _{DSS} | Drain to Source Breakdown Voltage | $I_{D} = -250 \ \mu A, \ V_{GS} = 0 \ V$ | -20 | | | V |
| ΔBV _{DSS} ΔT _J | Breakdown Voltage Temperature Coefficient | $I_D = -250 \ \mu\text{A}$, referenced to 25 °C | | 22 | | mV/°C |
| IDSS | Zero Gate Voltage Drain Current | $V_{DS} = -16 V, V_{GS} = 0 V$ | | | -1 | μΑ |
| I _{GSS} | Gate to Source Leakage Current | $V_{GS} = \pm 8 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$ | | | ±10 | μΑ |
| On Chara | acteristics | | | | | |
| V _{GS(th)} | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_{D} = -250 \ \mu A$ | -0.35 | -0.6 | -1.0 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | $I_D = -250 \ \mu\text{A}$, referenced to 25 °C | | -4 | | mV/°C |
| | Static Drain to Source On Resistance | V _{GS} = -4.5 V, I _D = -2.0 A | | 55 | 75 | mΩ |
| | | V _{GS} = -2.5 V, I _D = -1.5A | | 65 | 90 | |
| r _{DS(on)} | | V_{GS} = -1.8 V, I _D = -1.0 A | | 80 | 110 | |
| DS(on) | | V_{GS} = -1.5 V, I _D = -1.0 A | | 100 | 150 | |
| | | V _{GS} = -4.5 V, I _D = -2.0 A, T _J =125°C | | 80 | 124 | |
| 9 _{FS} | Forward Transconductance | V _{DD} = -5 V, I _D = -3.3 A | | 14 | | S |
| Dynamic | Characteristics | | | | | |
| C _{iss} | Input Capacitance | | | 750 | 1000 | pF |
| C _{oss} | Output Capacitance | V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz | | 110 | 145 | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 100 | 150 | pF |
| Switching | g Characteristics | | | | | |
| | | | | 5.0 | 40 | |
| t _{d(on)} | Turn-On Delay Time | | | 5.9 | 12 | ns |

| ld(on) | Tum-On Delay Time | | 5.9 | 12 | ns |
|---------------------|-------------------------------|-------------------------------------------------------------------------------|-----|-----|----|
| t _r | Rise Time | V _{DD} = -10 V, I _D = -3.3 A, | 9.1 | 18 | ns |
| t _{d(off)} | Turn-Off Delay Time | V_{GS} = -4.5 V, R_{GEN} = 6 Ω | 124 | 198 | ns |
| t _f | Fall Time | | 88 | 140 | ns |
| Qg | Total Gate Charge | V 45VVV 40V | 12 | 17 | nC |
| Q _{gs} | Gate to Source Charge | V _{GS} = -4.5 V, V _{DD} = -10 V, I _D = -3.3 A | 1.1 | | nC |
| Q _{gd} | Gate to Drain "Miller" Charge | | 3.4 | | nC |

Drain-Source Diode Characteristics

| I _S | Maximum Continuous Drain-Source Diode Forward Current | | | -1.1 | А |
|-----------------|-------------------------------------------------------|----------------------------------------------------------------|------|------|----|
| V _{SD} | Source to Drain Diode Forward Voltage | $V_{GS} = 0 V, I_S = -1.3 A$ (Note 2) | -0.7 | -1.2 | V |
| t _{rr} | Reverse Recovery Time | - I _F = -3.3 A, di/dt = 100 A/μs | 61 | 98 | ns |
| Q _{rr} | Reverse Recovery Charge | $F = -3.3 \text{ A}, \text{ u/ut} = 100 \text{ A/}\mu\text{S}$ | 29 | 47 | nC |

Notes:

1. R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a. 75 °C/W when mounted on a 1 in² pad of 2 oz copper.



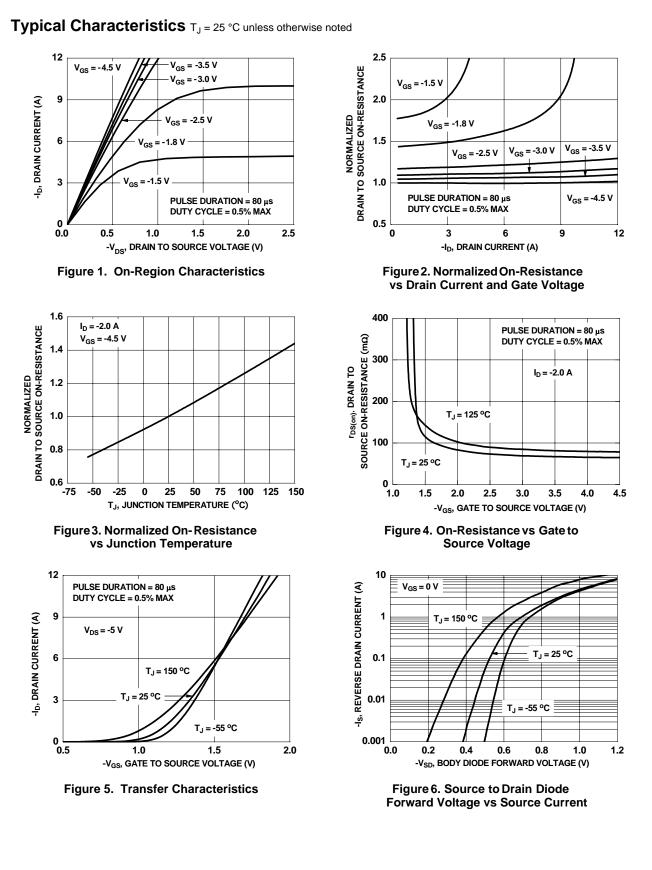
b. 260 °C/W when mounted on a minimum pad of 2 oz copper.

2. Pulse Test: Pulse Width < 300μ s, Duty cycle < 2.0%.

3. The diode connected between the gate and source serves only as protection ESD. No gate overvoltage rating is implied.

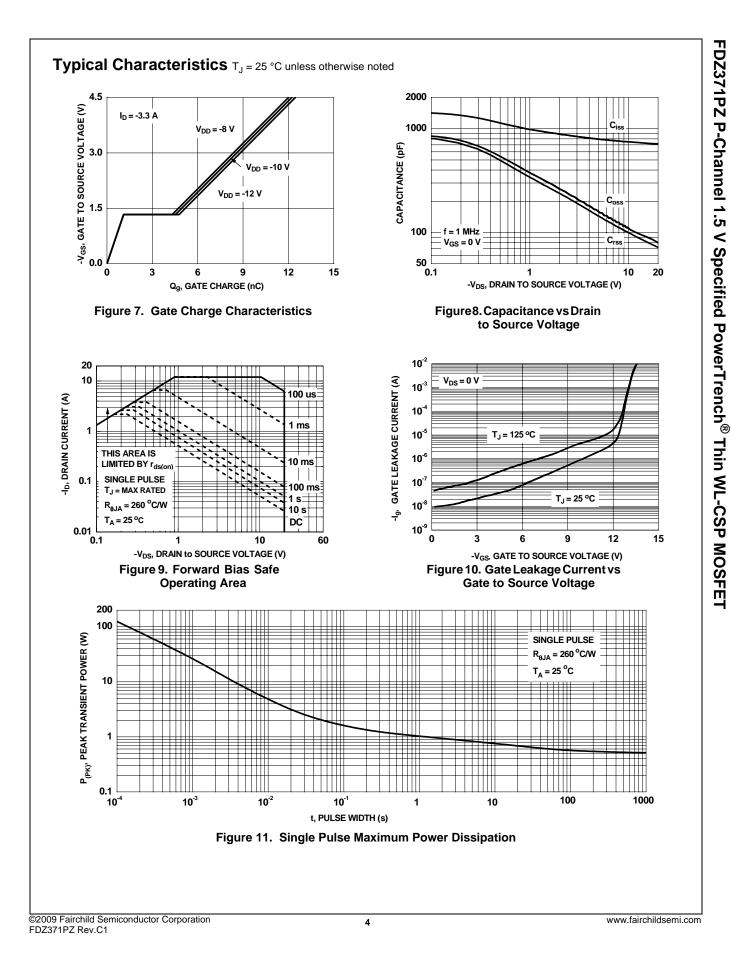
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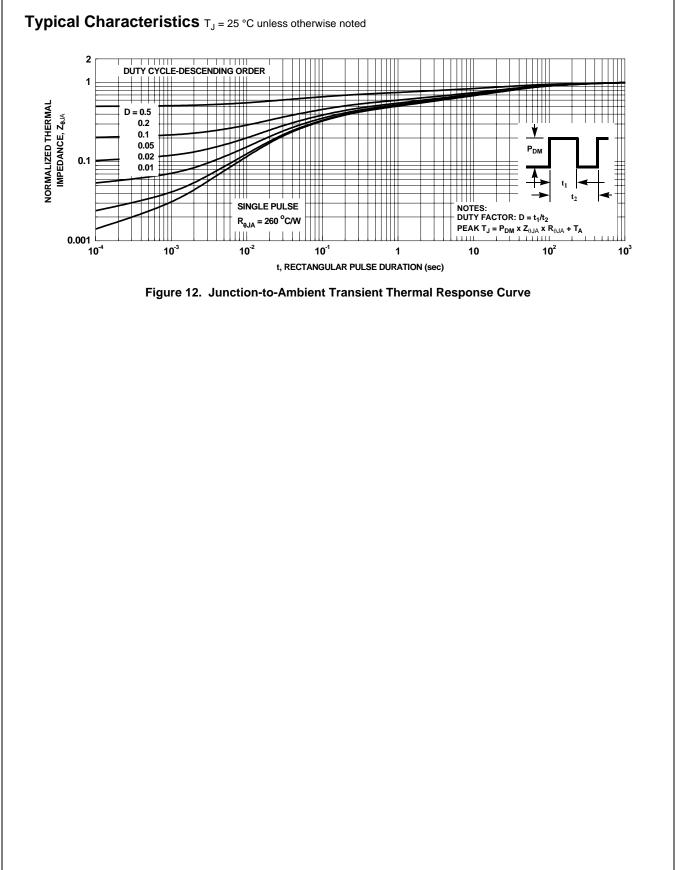
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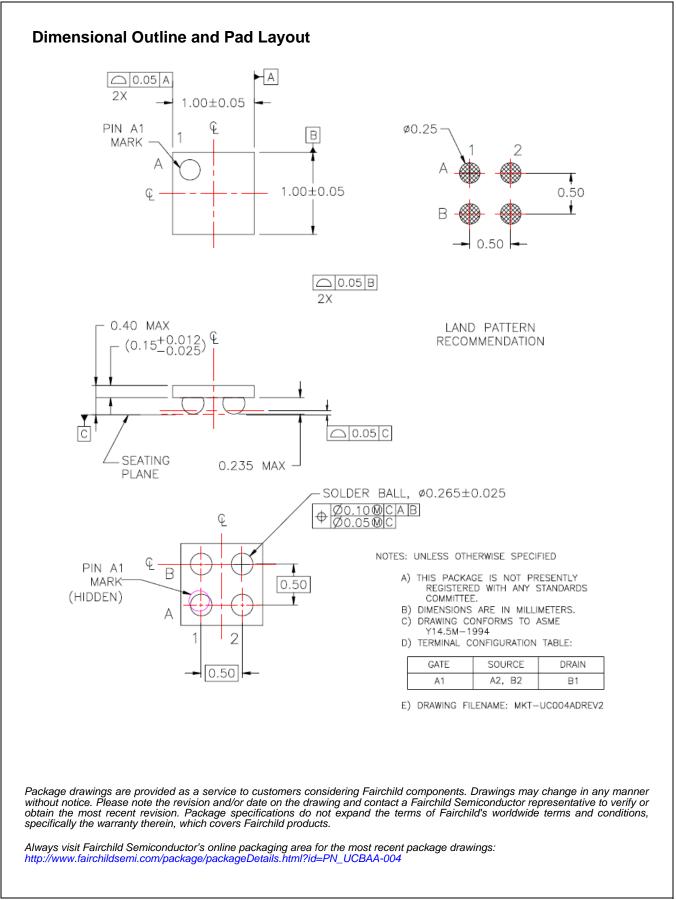


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